

Notice of References Cited

Application/Control No.

10/579,565

Applicant(s)/Patent Under
Reexamination
HYDE ET AL.

Examiner

Hai C. Pham

Art Unit

2861

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,909,232	06-1999	Goto et al.	347/187
*	B	US-6,633,319	10-2003	Yamakawa et al.	347/172
*	C	US-7,256,803	08-2007	Hilbert, John	347/171
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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